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Electronic states of epitaxial thin films of \( \text{La}_{0.9}\text{Sn}_{0.1}\text{MnO}_3 \) and \( \text{La}_{0.9}\text{Ca}_{0.1}\text{MnO}_3 \)

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Structure, transport properties, and electronic structure of epitaxial thin films \( \text{La}_{0.9}\text{Sn}_{0.1}\text{MnO}_3 \) and \( \text{La}_{0.9}\text{Ca}_{0.1}\text{MnO}_3 \) have been experimentally studied. According to the Hall-effect measurement, \( \text{La}_{0.9}\text{Sn}_{0.1}\text{MnO}_3 \) is an \( n \)-type conductor in the metallic state due to the substitution of Sn for La. X-ray photoelectron spectroscopy spectra revealed a shift of the Fermi level and the Mn ionic core level of \( \text{La}_{0.9}\text{Sn}_{0.1}\text{MnO}_3 \) in comparison with \( \text{La}_{0.9}\text{Ca}_{0.1}\text{MnO}_3 \). The difference between the Mn-\( 2p \) spectra of \( \text{La}_{0.9}\text{Sn}_{0.1}\text{MnO}_3 \) and \( \text{La}_{0.9}\text{Ca}_{0.1}\text{MnO}_3 \) implies that Mn ions in the former are at a Mn\(^{3+}/\text{Mn}^{4+} \) mixed-valence state, which is significantly different from the divalent-element-doped manganese oxides, where the Mn ions are in the mixed-valence state of Mn\(^{3+}/\text{Mn}^{4+} \).

Numerous studies have focused on the family of doped manganese perovskite oxides \( \text{R}_1-x\text{A}_x\text{MnO}_3 \) recently, where \( \text{R} \) is a trivalent rare-earth element and \( \text{A} \) is a divalent element such as Ca, Sr, Ba, and Pb, etc. In this kind of material, an insulator-to-metal transition occurs that is usually accompanied by a paramagnetic-to-ferromagnetic transition, and a colossal magnetoresistance (CMR) effect takes place near the Curie temperature.\(^1 \) It is believed that these phenomena are due to the double exchange interaction and Jahn-Teller effect.\(^2 \) These oxides are of great importance both for scientific study and practical applications. Unfortunately, the low working temperature and considerable noise has restricted most commercial applications. It has been experimentally proven that the conventional divalent-ion-doped manganite exhibits a \( p \)-type conductivity. However, we can change the character of the charge carrier in the compound by replacing La\(^{3+} \) with Sn\(^{4+} \). A combination of the \( n \)- and \( p \)-type oxides could form a \( p-n \) junction, producing a functional device for all oxides. The lanthanum or tin might be slightly deficient due to a loss during the high-temperature process.

In this paper we report the electronic structure and transport properties of \( \text{La}_{0.9}\text{Sn}_{0.1}\text{MnO}_3 \) (LSMO). Hall-effect measurements have suggested \( n \)-type conductivity in LSMO. Compared to \( p \)-type \( \text{La}_{0.9}\text{Ca}_{0.1}\text{MnO}_3 \) (LCMO) thin films, a chemical shift of the Fermi level and a widening of the valence band were observed in LSMO based on the study of x-ray photoelectron (XPS) spectra. From an analysis of the Mn-\( 2p \) spectra, Mn ions in the LSMO film could be at a Mn\(^{2+}/\text{Mn}^{3+} \) mixed-valence state, instead of Mn\(^{3+}/\text{Mn}^{4+} \) as in the LCMO film.

The thin films were fabricated by using pulse laser deposition. The targets of LSMO and LCMO were prepared by the conventional solid-state reaction method. The stoichiometric mixture of high-purity La\(_2\)O\(_3\), Mn\(_2\)O\(_4\), and SnO\(_2\) or CaCO\(_3\) powder was milled, pressed, and presintered three times. Then the powder was pressed into a disk of 50 mm in diameter and sintered at 1203 \( K \), for LSMO, and 1573 \( K \), for LCMO. Single-crystal SrTiO\(_3\) (100) was used as a substrate. The deposition temperature was about 900 \( K \), measured by a \( k \)-type thermocouple inserted into the heater block. The deposition was performed in pure oxygen at a pressure of \( 2 \times 10^{-2} \) mbar. The power of the pulse laser beam was about 300 mJ and the frequency was 10 Hz. The growing process was halted when the thickness of the film was about 300 nm and then the film was annealed at about 1073 \( K \) for about 4 h in air.

All the grown films were examined by a SIEMENS D5000 x-ray diffractometer with Cu-\( K\alpha \) radiation. Figure 1 presents a typical x-ray-diffraction spectrum of the LSMO film. No peaks from the secondary phases such as tin oxides are visible, clearly demonstrating that the film is of single phase and exhibits a perfect (001) orientation. The diffraction peaks agree well with that of the \( ABO_3 \) structure. The out-of-plane lattice constant of LSMO was measured to be 3.8748 \( \text{Å} \). The partial substitution of Sn for La in LaMnO\(_3\) induces minor lattice constrictions due to the different ionic radii of Sn and La. The lanthanum or tin might be slightly deficient due to a loss during the high-temperature process. However, the deficit of La or Sn was found very small, as reflected by energy-dispersive x-ray analysis. The average composition for LSMO films is \( \text{La}_{0.88}\text{Sn}_{0.12}\text{Mn}=0.88:0.086:1 \), approaching stoichiometry.

The temperature dependence of the resistivity was measured by a standard four-probe method in the range of 4.2–300 \( K \) under external magnetic fields of 0–4 \( T \). The rather

\[ \text{FIG. 1. Typical x-ray-diffraction pattern of the La}_{0.9}\text{Sn}_{0.1}\text{MnO}_3 \] epitaxial thin films. The insets show the enlarged (400) peaks.
sharp transition implies the high purity in the phase structure, as seen in Fig. 2. The experimental results revealed that these films exhibited a standard CMR behavior and the magnetic resistance ratio, $\rho(H)/\rho(0)$, was about 85% near the Curie temperature ($\sim 243$ K). Its $\rho - T$ dependence is similar to that of LSMO thin films and bulk material.\textsuperscript{2} The resistivity of these LSMO films is about $10^{-2} - 10^{-3}$ Ω cm, remarkably lower than that of La-deficient La$_{0.9}$MnO$_3$ ($\rho = 8.6$ Ω cm).\textsuperscript{6} As reported by Gupta \textit{et al.} and McGuire \textit{et al.}, the Curie temperature of the La$_{0.9}$MnO$_3$ thin films was $\sim 130$ K.\textsuperscript{6,7} The maximum value of $T_c$ for thin films of La$_{0.9}$MnO$_3 - \delta$ with an annealing in oxygen at 850°C could increase to $\sim 180$ K, which is still much lower than that of our samples ($T_c \sim 243$ K for our LSMO films). Such a comparison suggests that our films were not formed as a mixture of La$_{0.9}$MnO$_3$ and SnO$_2$. The Sn atoms in our LSMO films should occupy the La site.

It is well known that the partial substitution of La$^{3+}$ by a divalent element in LaMnO$_3$ may introduce a mixture system of Mn$^{3+}$ and Mn$^{4+}$ ions. The double exchange interaction between Mn ions, combined with the Jahn-Teller distortion model, qualitatively explained the CMR behavior and related transitions.\textsuperscript{5} That is to say that the Mn$^{3+}$ ion has an electron configuration $t_{2g}^{3}e_{g}^{1}$. The low-energy $t_{2g}^{3}$ triplet state contributes a local spin of $S = \frac{3}{2}$, and the $e_{g}^{1}$ state electron is either itinerant or localized, depending on the local spin orientation. The $e_{g}^{1}$ electron hopping between Mn$^{3+}$ and Mn$^{4+}$ and its dependence on magnetic field also qualitatively describe the magnetoresistance behavior. In order to explain the insulatorlike behavior at a higher temperature, the Jahn-Teller-type polaron effect has to be considered in the double exchange model. If a part of the La$^{3+}$ ions was substituted by four or five valence elements such as Sn, Te, Sb, etc., a mixed-valence system of Mn$^{3+}$ and Mn$^{2+}$ ions could be observed and the electron-doping feature would be expected. For LSMO films, XPS revealed that the binding energy for Sn-$3d_{5/2}$, $-3d_{3/2}$, and $-4d$ were 486.44, 494.88, and 25.81 eV respectively, which are very close to that of SnO$_2$.\textsuperscript{7} Thus the experiments confirmed that the Sn ions in the La$_{0.9}$Sn$_{0.1}$MnO$_3$ sample are in the four-valence state.

\begin{figure}[h]
\centering
\includegraphics[width=\textwidth]{resistivity.png}
\caption{The temperature dependence of resistivity of one of our LSMO films.}
\end{figure}

\begin{figure}[h]
\centering
\includegraphics[width=\textwidth]{hall_resistivity.png}
\caption{Hall resistivity vs magnetic-field curves for La$_{0.9}$Sn$_{0.1}$MnO$_3$ at temperatures 60 and 236 K.}
\end{figure}

In order to understand the picture of charge transport in the sample, measurements on the anomalous Hall effect were performed on La$_{0.9}$Sn$_{0.1}$MnO$_3$ films using an Oxford superconducting magnet system and a dc current source. In order to gain correct Hall voltage and avoid the magnetic hysteresis effect in low fields, the Hall voltage was obtained by proper averaging of the signals measured at reversal directions of the measuring current and field. In practice, we took six sets of Hall voltage in the sweeping field (from 6 to $-6$ T) and the Hall voltage was obtained by averaging the last five sets of data. Then we calculated the Hall resistivity based on the dimension of sample and measuring dc current (5 mA). Figure 3 shows the function curves of the measured Hall resistivity vs external magnetic field at 60 and 236 K, respectively.

The anomalous Hall effect was first discovered in ferromagnetic metal, and then observed in manganese pervoskite oxides.\textsuperscript{8} In general, for a ferromagnetic material in an applied magnetic field $H$, the dependence of transverse resistivity vs field can be written as

$$\rho_{xy} = R_B + R_A \mu_B M$$

where $R_B$ and $R_A$ are ordinary and anomalous Hall coefficients, respectively, $M$ is the magnetization and $N$ is the demagnetization factor. The Hall resistivity is about $10^{-4}$ Ω cm, that is, close to the Hall resistivity value of Tl$_2$Mn$_2$O$_7$ and La$_{2/3}$Sr$_{1/3}$MnO$_3$ ($A = $Cu, Sr) thin films.\textsuperscript{9} At a low field, the $\rho_{xy}$ increases steeply with the field, reaches a maximum at about 0.6 and 1 T for temperatures 60 and 236 K, respectively, and then decreases with an approximate linear slope. The initial part of $\rho vs H$ curves is dominated by the magnetization of the sample rather than by the external magnetic field. At high fields, the magnetization is saturated and is field independent. The slope $dR_H/dB$ is given by ordinary Hall contribution induced by Lorentz forces on charge carriers, $R_H = \mu_B \mu B$, and the effective carrier density $n_{eff} = 1/e R_0$. The experimental results on LSMO
films thus confirmed that the anomalous Hall coefficients are positive and the ordinary Hall coefficients are negative, different from the behavior of the divalent elements doping manganese perovskite oxides. The negative linear slope of the curves differs from those hole-doped $ABO_3$ compounds. The carrier density turns out to be temperature dependent rather than field dependent. At 60 K we assume that the field dependence of Hall resistivity is a linear function; the Hall coefficient is about $4.77 \text{ cm}^3/\text{C}$, and the carrier density is about $0.13 \times 10^{19} \text{ cm}^{-3}$. For the temperature of 236 K, that is near the Curie temperature, the magnetic-field dependence of the Hall resistivity exhibited activated behavior, which was observed in $La_{2/3}Ca_{1/3}MnO_3$ in the region of high temperature.

As discussed above, LSMO shows different behaviors when compared with the hole-doping LCMO. Further evidence may be derived from the XPS measurements. Al-Kα radiation was used and the scanning step was 0.05 eV. The background yielded by the second electrons was subtracted for clarity and the intensity was normalized to integrated intensity. All spectra were fitted with a Gaussian function. Figure 4 presents the valence-band spectra of LSMO and LCMO. The fine structure of the peaks is similar to other manganites, which is due to the nonbonding and bonding states of the hybridization between Mn-3$d$ and O-2$p$ electrons. A variance of bandwidth and a chemical shift of the valence-band top, $~0.4$ eV towards to the Fermi level, are observed. Compared to LCMO, the bandwidth was widened for LSMO. These phenomena are consistent with the relative variation of the valence band of LSMO (~n type) and LCMO (~p type), though both compounds were in the mixed-valence states of Mn$^{3+}$ and Mn$^{4+}$. In previous works, it has been reported that the Fermi level and bandwidth were functions of temperature, doping level, and pressure. For hole-doped manganese oxides, as the average radius of rare-earth-site ions decreases, the Mn-O-Mn bond angle decreases, which reduces the bandwidth. Theionic radius of Sn$^{4+}$ is smaller than that of Ca$^{2+}$, while the bandwidth of LSMO is wider than that of LCMO, which suggests that the effects of Sn doping might be a factor dominating the band structure. Figure 5 shows the XPS pattern of Mn 3$p$ and 2$p$ core level, and the difference between the Mn-2$p$ spectra of $La_{0.9}Sn_{0.1}MnO_3$ and $La_{0.9}Ca_{0.1}MnO_3$.

FIG. 4. Valence-band spectra of the $La_{0.9}Sn_{0.1}MnO_3$ and $La_{0.9}Sn_{0.1}MnO_3$ films.

FIG. 5. XPS spectra of Mn 3$p$ and Mn 2$p$ core level, and the difference between the Mn-2$p$ spectra of $La_{0.9}Sn_{0.1}MnO_3$ and $La_{0.9}Ca_{0.1}MnO_3$. 

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also implies that the two compounds are in different mixed-valence states. In addition, the peak positions of Mn-2p_{3/2} and -2p in the LSMO film are found about 641.35 and 48.22 eV, respectively. The corresponding values for LCMO are about 642.13 and 49.05 eV. A chemical shift of about 0.8 eV in the Mn-3p and -2p levels could be found. In order to explore the variance between Mn-2p spectra, the difference between Mn-2p spectra of the LSMO and LCMO films was also plotted in Fig. 5. There are two positive peaks at about 640 and 652 eV, and two negative peaks at about 643 and 654 eV. The former two peaks are very close to that of 2p_{3/2} and 2p_{1/2} states of MnO (640.6 and 652.2 eV), while the latter two to the peaks of the 2p_{3/2} and 2p_{1/2} states of MnO_2 (642.2 and 653.8 eV). This implies that the number of Mn^{4+} ions decreased or vanished and the Mn^{2+} appeared in LSMO. Therefore, the Mn^{2+} ion may replace Mn^{4+} due to the substitution of Sn for Ca in the compound. That is to say, Mn ions in LSMO are at a Mn^{2+}/Mn^{4+} mixed-valence state, different from the conventional CMR materials that show a Mn^{3+}/Mn^{4+} mixed-valence state.

In conclusion, the experimental results of this XPS study revealed that the Sn ions were in the four-valence state in the LSMO films. In comparison to LCMO films, the bandwidth of valence band was widened and the Fermi energy level was shifted by about −0.4 eV. The difference curve between the Mn-2p spectrum of LSMO and that of LCMO showed that the substitution of Sn for Ca may transfer manganese perovskite from the Mn^{3+}/Mn^{4+} mixed-valence system into an Mn^{2+}/Mn^{4+} one, which implies that the mechanism for the CMR behavior could be different from that of the hole-doped manganites.

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